

MH233 Hall-effect sensor is a temperature stable, stress-resistant, Low Tolerance of Sensitivity Ultra-power switch. Superior high-temperature performance is made possible through a dynamic offset cancellation that utilizes chopper-stabilization. This method reduces the offset voltage normally caused by device over molding, temperature dependencies, and thermal stress.

MH233 is special made for low operation voltage, 2.7V, to active the chip which includes the following on a single silicon chip: voltage regulator, Hall voltage generator, small-signal amplifier, chopper stabilization, Schmitt trigger, CMOS output driver. Advanced CMOS wafer fabrication processing is used to take advantage of low-voltage requirements, component matching, very low input-offset errors, and small component geometries. This device can be operated on not only unipolar S or N, but omni-polar magnetic field.

The package type is in a Halogen Free version has been verified by third party Lab.

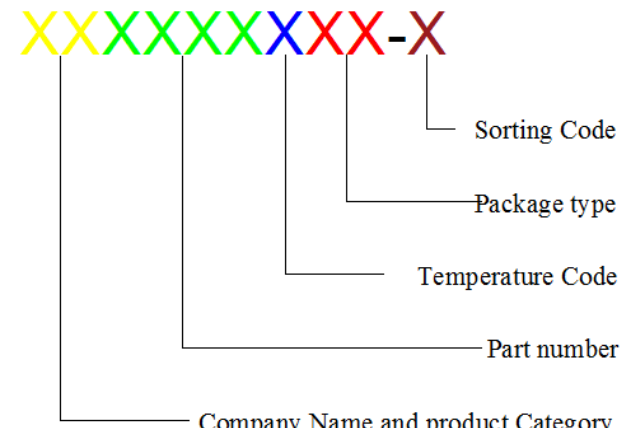
Features and Benefits

- CMOS Hall IC Technology
- Strong RF noise protection
- 2.7 to 5.5V for battery-powered applications
- Omni polar, output switches with absolute value of North or South pole from magnet
- Operation down to 2.7V, Micro power consumption
- High Sensitivity for reed switch replacement applications
- Low sensitivity drift in crossing of Temp. rang
- Multi Small Size option
- Ultra low power consumption at 1.6uA (Avg)
- High ESD Protection, HBM > ±4KV(min)
- Operation with South Pole (OUT1) or North Pole (OUT2)
- Totem-pole output
- RoHS compliant 2011/65/EU and Halogen Free

Applications

- Solid state switch
- Handheld wireless Handset Awake Switch(Flip Cell/PHS Phone/Note Book/Flip Video Set)
- Magnet proximity sensor for reed switch replacement in low duty cycle applications
- Water Meter
- PDA
- Tab PC
- Security
- Smart meter
- 3C
- TWS

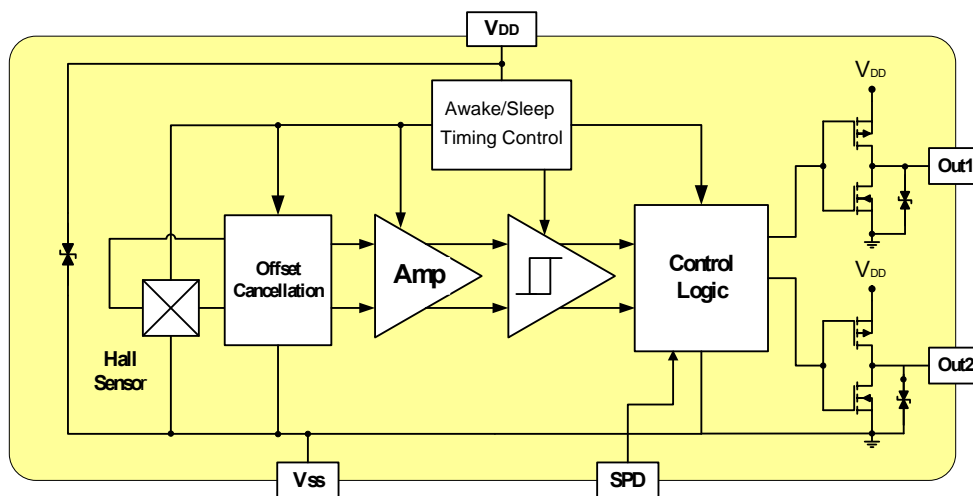
Ordering Information

	<p>Company Name and Product Category MH:MST Hall Effect/MP:MST Power MOSFET</p> <p>Part number 181,182,183,184,185,248,249,276,477,381,381F,381R,382..... If part # is just 3 digits, the fourth digit will be omitted.</p> <p>Temperature range E: 85 °C, I: 105 °C, K: 125 °C, L: 150 °C</p> <p>Package type UA:TO-92S,VK:TO-92S(4pin),VF:TO-92S(5pin),SO:SOT-23, SQ:QFN-3,ST:TSOT-23,SN:SOT-553,SF:SOT-89(5pin)</p> <p>Sorting α,β,Blank.....</p>
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Part No.	Temperature Suffix	Package Type
MH233NEUA	E (-40°C to + 85°C)	UA (TO-92S)
MH233SEUA	E (-40°C to + 85°C)	UA (TO-92S)
MH233NEST	E (-40°C to + 85°C)	ST (TSOT-23)
MH233SEST	E (-40°C to + 85°C)	ST (TSOT-23)
MH233ESD	E(-40°C to +85°C)	SD (DFN2*2-6L)
MH233ESS	E (-40°C to + 85°C)	SS (QFN1x1-4L)

Custom sensitivity selection is available by MST sorting technology

Functional Diagram



Note: Static sensitive device; please observe ESD precautions. Reverse V_{DD} protection is not included. For reverse voltage protection, a 100Ω resistor in series with V_{DD} is recommended.

MH233, HBM > ±4KV which is verified by third party lab.

Absolute Maximum Ratings At($T_a=25^\circ\text{C}$)

Characteristics		Values	Unit
Supply voltage, (V_{DD})		6.0	V
Output Voltage, (V_{out})		6.0	V
Reverse Voltage, (V_{DD} / V_{out})		-0.3	V
Magnetic flux density		Unlimited	Gauss
Output current, (I_{out})		5	mA
Operating temperature range, (T_a)		-40 to +85	$^\circ\text{C}$
Storage temperature range, (T_s)		-65 to +150	$^\circ\text{C}$
Maximum Junction Temp, (T_j)		150	$^\circ\text{C}$
Thermal Resistance	(θ_{JA}) UA/ST/SS/SD	206/543/300/160	$^\circ\text{C}/\text{A}$
	(θ_{JC}) UA/ST/SS/SD	148/410/52/35	$^\circ\text{C}/\text{A}$
Package Power Dissipation, (P_D) UA/ST/SS/SD		606/230/416/780	mW

Note: Exceeding the absolute maximum ratings may cause permanent damage. Exposure to absolute maximum-rated conditions for extended periods may affect device reliability.

Electrical Specifications

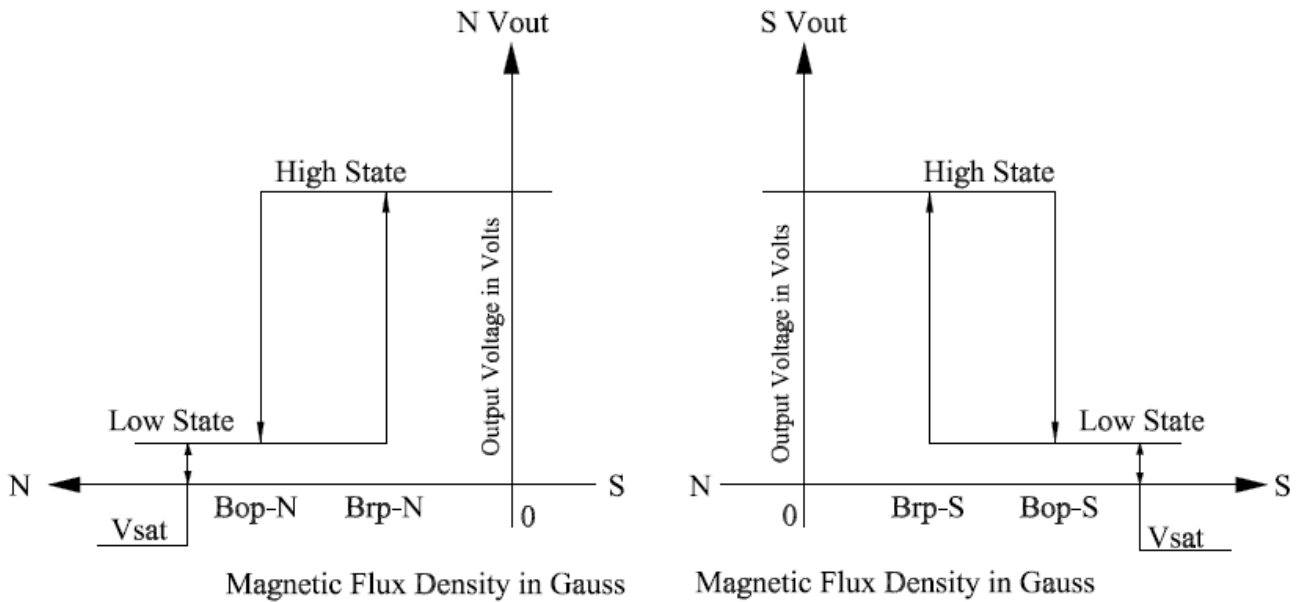
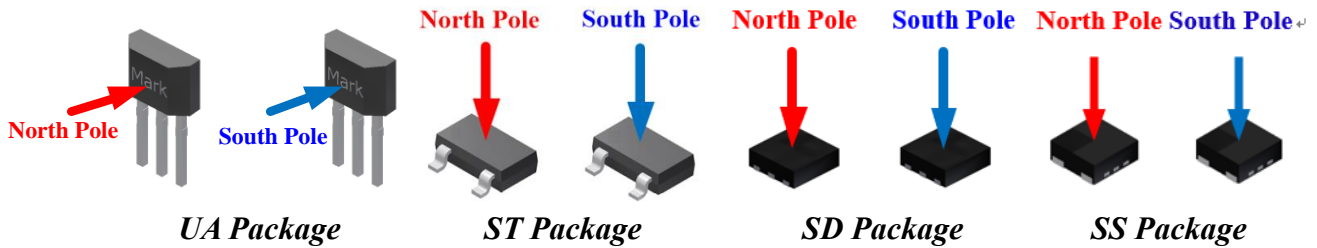
DC Operating Parameters : $T_a=25^\circ\text{C}$, $V_{DD}=3.0\text{V}$

Parameters	Test Conditions	Min	Typ	Max	Units
Supply Voltage (V_{DD})	Operating	2.7		5.5	V
Supply Current (I_{DD})	Awake State		2.0		mA
	Sleep State		1.0		μA
	Average (SPD=Hi)		1.6/(135)		μA
Output High Voltage (V_{OH})	$I_{OUT}=1.0\text{mA}$ (Source)	VDD-0.2			V
Output Low Voltage (V_{OL})	$I_{OUT}=1.0\text{mA}$ (Sink)			0.2	V
Awake mode time, (T_{aw})	Operating		20	40	μs
Sleep mode time, (T_{SL})	Operating (SPD=Hi)		80(0.16)	150(0.32)	mS
Duty Cycle, (D, C)	(SPD=Hi)		0.025/(12.5)		%
Power-On Time, (T_{PO})			16	32	nS
Output Switch Time, (T_{SW})	Operating (SPD=Hi)		80(0.2)	160(0.4)	mS
Output Switch Frequency, (F_{SW})	Operating (SPD=Hi)	15(6.5k)			Hz
Electro-Static Discharge	HBM	4			KV
Operate Point, BOPS (Output S)	$B > \text{BOPS}$,	50		90	Gauss
Release Point, BRPS (Output S)	$B < \text{BRPS}$,	40		80	Gauss
Operate Point, BOPN (Output N)	$B < \text{BOPN}$,	-90		-50	Gauss
Release Point, BRPN (Output N)	$B > \text{BRPN}$,	-80		-40	Gauss
Hysteresis, (BHYS)	$ \text{BOPX} - \text{BRPX} $		10		Gauss

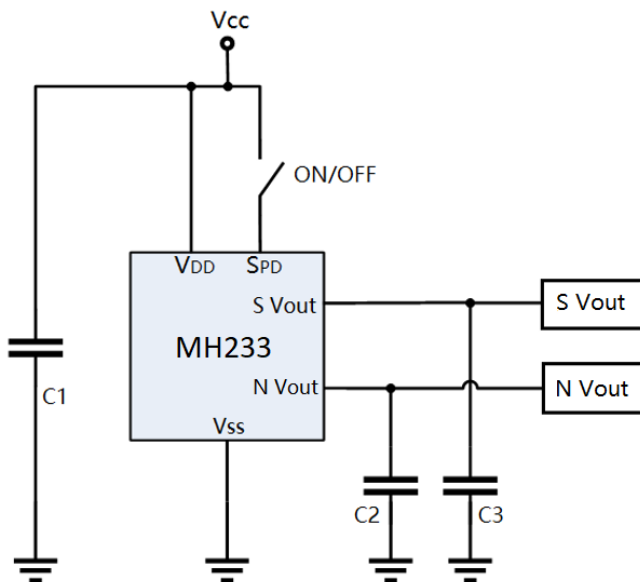
MH233NEUA/SEUA/NEST/SEST/ESS/ESD Output Behavior versus Magnetic Polar

DC Operating Parameters: $T_a = -40$ to 85°C , $V_{DD} = 2.7\text{V}$ to 5.5V

Parameter	Test condition	S vout	Test condition	N Vout
South pole	$B > B_{OPS}$	Low	--	High
Null or weak magnetic field	$B=0$ or $B < B_{RPS}$	High	$B=0$ or $B > B_{RPN}$	High
North pole	--	High	$B < B_{OPN}$	Low



Typical application circuit

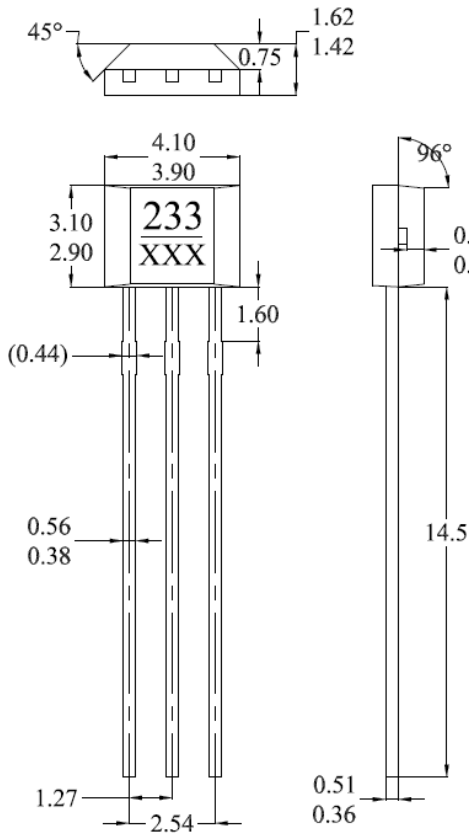


C1 : 10nF

C2 : 100pF

Sensor Location, package dimension and marking

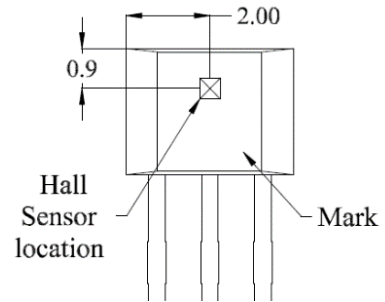
MH233SEUA Package



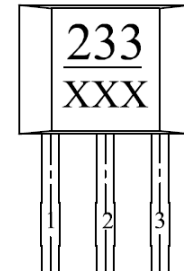
NOTES:

1. Controlling dimension: mm
2. Leads must be free of flash and plating voids
3. Do not bend leads within 1 mm of lead to package interface.
4. PINOUT:
Pin 1 VCC
Pin 2 GND
Pin 3 Output
5. XXX; 1st X=Year;
2nd and 3rd XX=Week

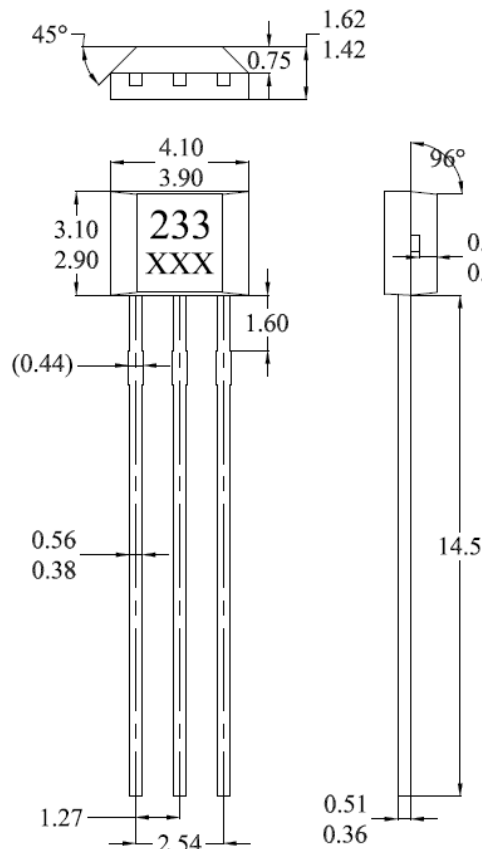
Hall Chip location



Output Pin Assignment (Top view)



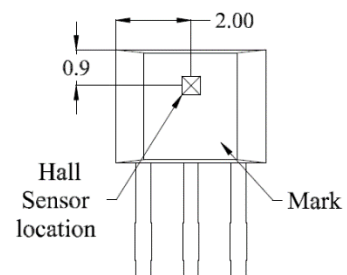
MH233NEUA Package



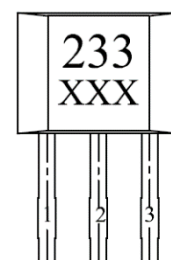
NOTES:

1. Controlling dimension: mm
2. Leads must be free of flash and plating voids
3. Do not bend leads within 1 mm of lead to package interface.
4. PINOUT:
Pin 1 VCC
Pin 2 GND
Pin 3 Output
5. XXX; 1st X=Year;
2nd and 3rd XX=Week

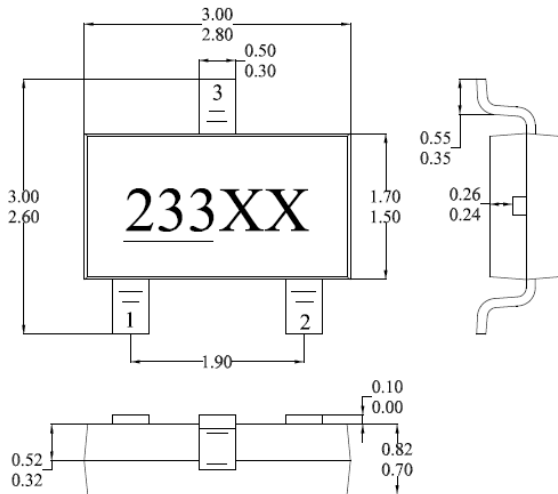
Hall Chip location



Output Pin Assignment (Top view)



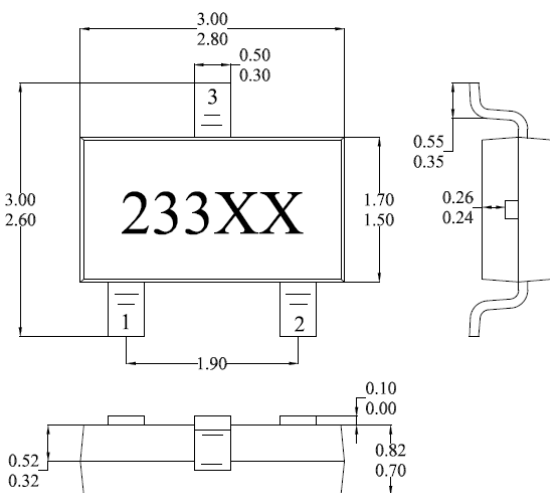
MH233SEST Package (Top View)



NOTES:

- PINOUT (See Top View at left :)
Pin 1 V_{DD}
Pin 2 Output
Pin 3 GND
- Controlling dimension: mm
- Lead thickness after solder plating will be 0.254mm maximum
- XX: Date Code, Refer to DC table

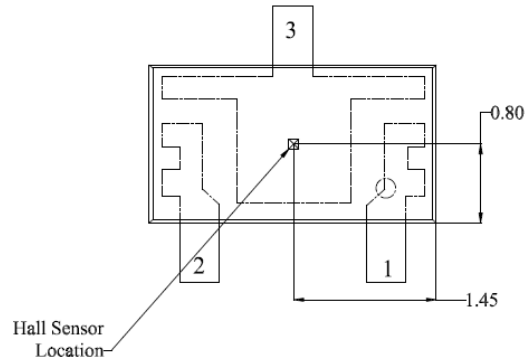
MH233NEST Package (Top View)



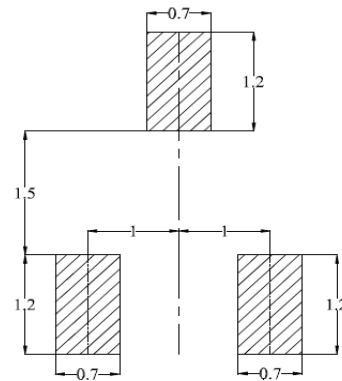
NOTES:

- PINOUT (See Top View at left :)
Pin 1 V_{DD}
Pin 2 Output
Pin 3 GND
- Controlling dimension: mm
- Lead thickness after solder plating will be 0.254mm maximum
- XX: Date Code, Refer to DC table

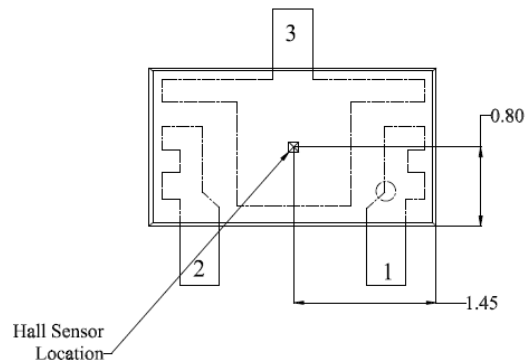
Hall Plate Chip Location (Bottom view)



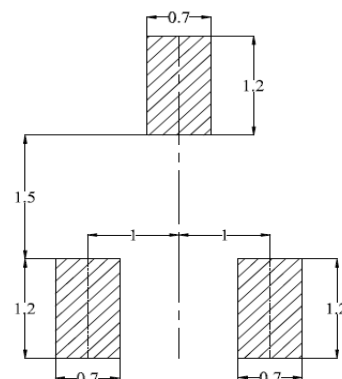
(For reference only) Land Pattern



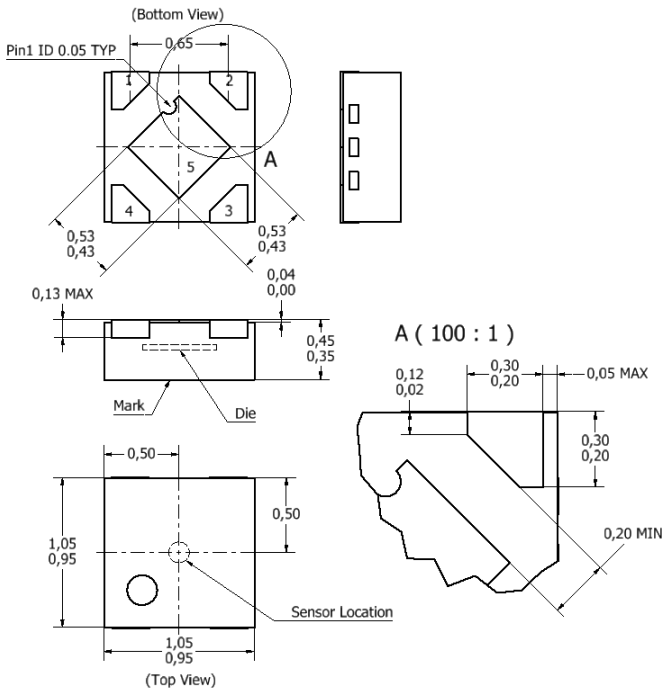
Hall Plate Chip Location (Bottom view)



(For reference only) Land Pattern



SS Package (DFN 1.0*1.0-4L)



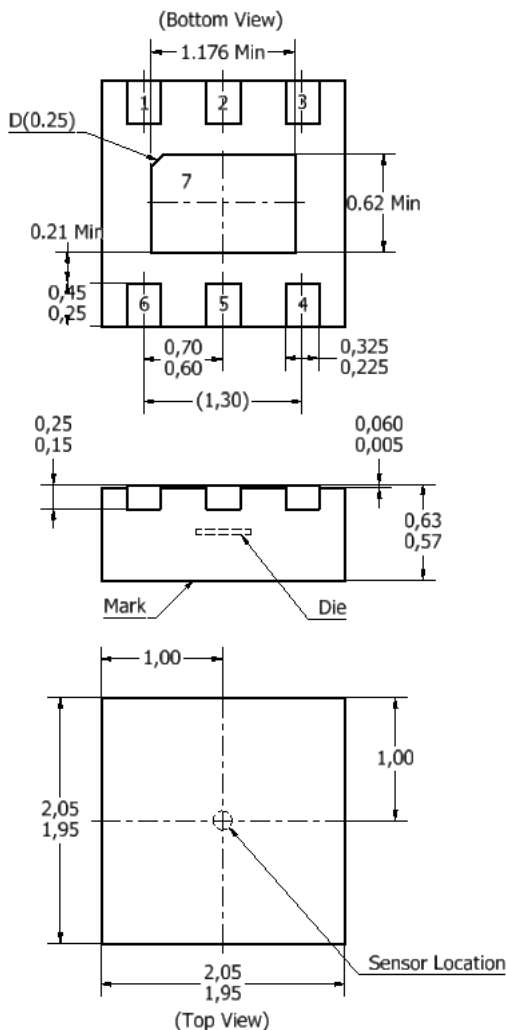
NOTES:

Controlling dimension: mm

1. Leads must be free of flash and plating voids
2. Lead thickness after solder plating will be 0.254mm maximum
3. PINOUT:

Pin No.	Pin Name	Function
1	V _{DD}	Power Supply
2	V _{SS}	Ground
3	S V _{OUT}	Output1
4	N V _{OUT}	Output2
5	PAD	NC

SD Package (DFN2*2-6L)



NOTES:

1. Controlling dimension: mm
2. Leads must be free of flash and plating voids
3. Lead thickness after solder plating will be 0.254mm maximum
4. PINOUT:

Pin No.	Pin Name	Function
1	V _{DD}	Power Supply
2	N V _{OUT}	Output2
3	S V _{OUT}	Output1
4	N.C	N.C
5	V _{SS}	Ground
6	SPD	Set pin
7	PAD	Ground

5. (For reference only) Land pattern

